## Application/Control No. Applicant(s)/Patent Under Reexamination 10/699,009 MACKJUST ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Van T Trieu 2612 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 324/115 Α US-5,218,290 06-1993 Beckert et al. В US-С US-US-D Ε US-F US-G US-US-Н US-1 J US-Κ US-US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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## Application/Control No. Applicant(s)/Patent Under Reexamination 10/699,009 MACKJUST ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Van T Trieu 2612 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-5,825,353 10-1998 Will, Craig Alexander 345/184 В US-С US-D US-Ε US-F US-US-G US-Н US-Τ J US-Κ US-US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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